

General Description

The WSD6035DN is the highest performance trench Dual N-Ch MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSD6035DN meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

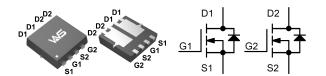
Product Summery

BVDSS	RDSON	ID
60V	20mΩ	40A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

DFN3x3-8-EP Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	40	Α
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	18	Α
I _{DM}	Pulsed Drain Current ² 114		Α
EAS	Single Pulse Avalanche Energy ³	25.5	mJ
I _{AS}	Avalanche Current	22	Α
P _D @T _C =25℃	Total Power Dissipation ⁴	34.7	W
P _D @T _A =25℃	Total Power Dissipation ⁴	2.5	W
T _{STG}	Storage Temperature Range -55 to 150		°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-Ambient ¹		80	°C/W
Rejc	Thermal Resistance Junction-Case ¹		3.6	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.063		V/°C
D	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =15A		20	32	0
R _{DS(ON)}		V _{GS} =4.5V , I _D =10A		30	38	mΩ
V _{GS(th)}	Gate Threshold Voltage	\/ -\/ -250::A	1.2	1.6	2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-5		mV/℃
	Drain Source Leekage Current	V _{DS} =48V , V _{GS} =0V , T _J =25℃		-	1	uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =55℃		-	5	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20 V$, V_{DS} = $0 V$		-	±100	nA
gfs	orward Transconductance	V _{DS} =5V , I _D =15A		17		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		3.2		Ω
Qg	Total Gate Charge (4.5V)	V _{DS} =30V , V _{GS} =4.5V , I _D =12A		12.6		
Q _{gs}	Gate-Source Charge			3.2		nC
Q _{gd}	Gate-Drain Charge			6.3		
T _{d(on)}	Turn-On Delay Time			8		
Tr	Rise Time	V _{DD} =30V , V _{GEN} =10V ,		14.2		
T _{d(off)}	Turn-Off Delay Time	R_{G} =3.3 Ω I_{D} =10A		24.4		ns
T _f	Fall Time			4.6]
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		1370		
Coss	Output Capacitance			85		pF
C _{rss}	Reverse Transfer Capacitance			64		

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V , L=0.5mH , I _{AS} =22A	20			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current ^{1,6}	V =V =0V Force Current		-	23	Α
I _{SM}	Pulsed Source Current ^{2,6}	$V_G=V_D=0V$, Force Current			46	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C		-	1.2	V
t _{rr}	Reverse Recovery Time			22		nS
Q _{rr}	Reverse Recovery Charge	lF=15A,dl/dt=100A/µs,T _J =25℃		51		nC

Note:

- 1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper,t<10 sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3.The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.5mH, I_{AS} =22A
- 4. The power dissipation is limited by 150 ℃ junction temperature
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

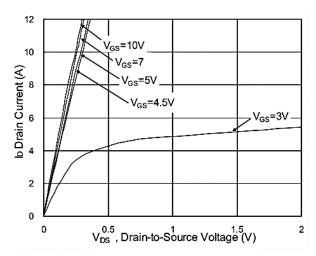


Fig.1 Typical Output Characteristics

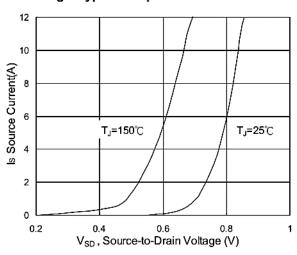


Fig.3 Forward Characteristics of Reverse

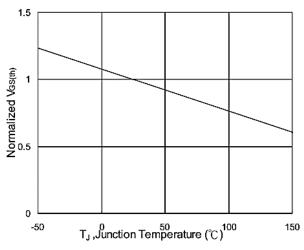


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

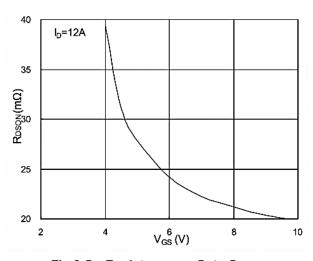


Fig.2 On-Resistance v.s Gate-Source

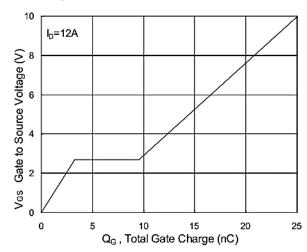


Fig.4 Gate-Charge Characteristics

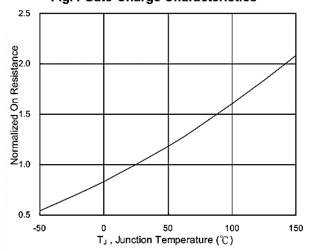
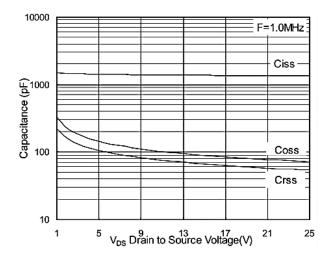


Fig.6 Normalized R_{DSON} v.s T_J





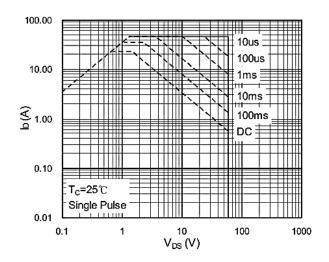


Fig.7 Capacitance

Fig.8 Safe Operating Area

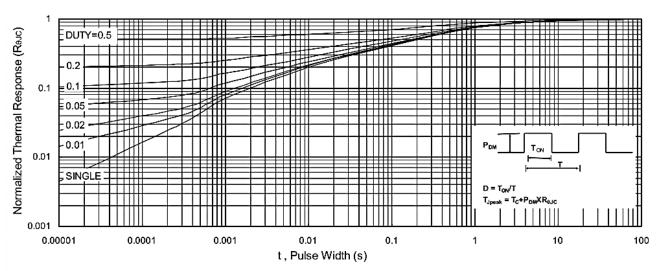


Fig.9 Normalized Maximum Transient Thermal Impedance

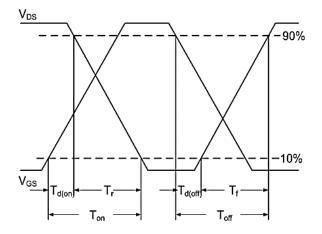


Fig.10 Switching Time Waveform

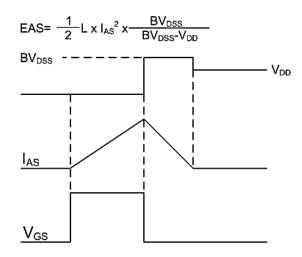


Fig.11 Unclamped Inductive Waveform



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